

IMPORTANT NOTICE

USAGE OF THE DAE4

The DAE unit is a delicate, high precision instrument and requires careful treatment by the user. There are no serviceable parts inside the DAE. Special attention shall be given to the following points:

Battery Exchange: The battery cover of the DAE4 unit is closed using a screw, over tightening the screw may cause the threads inside the DAE to wear out.

Shipping of the DAE: Before shipping the DAE to SPEAG for calibration, remove the batteries and pack the DAE in an antistatic bag. This antistatic bag shall then be packed into a larger box or container which protects the DAE from impacts during transportation. The package shall be marked to indicate that a fragile instrument is inside.

E-Stop Failures: Touch detection may be malfunctioning due to broken magnets in the E-stop. Rough handling of the E-stop may lead to damage of these magnets. Touch and collision errors are often caused by dust and dirt accumulated in the E-stop. To prevent E-stop failure, the customer shall always mount the probe to the DAE carefully and keep the DAE unit in a non-dusty environment if not used for measurements.

Repair: Minor repairs are performed at no extra cost during the calibration. However, SPEAG reserves the right to charge for any repair especially if rough unprofessional handling caused the defect.

DASY Configuration Files: Since the exact values of the DAE input resistances, as measured during the calibration procedure of a DAE unit, are not used by the DASY software, a nominal value of 200 MOhm is given in the corresponding configuration file.

Important Note:

Warranty and calibration is void if the DAE unit is disassembled partly or fully by the Customer.

Important Note:

Never attempt to grease or oil the E-stop assembly. Cleaning and readjusting of the E-stop assembly is allowed by certified SPEAG personnel only and is part of the calibration procedure.

Important Note:

To prevent damage of the DAE probe connector pins, use great care when installing the probe to the DAE. Carefully connect the probe with the connector notch oriented in the mating position. Avoid any rotational movement of the probe body versus the DAE while turning the locking nut of the connector. The same care shall be used when disconnecting the probe from the DAE.



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Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 0108**

Client **BTL Inc.**
Guangdong

Certificate No: **DAE4-1390_Nov24**

CALIBRATION CERTIFICATE

Object **DAE4 - SD 000 D04 BM - SN: 1390**

Calibration procedure(s) **QA CAL-06.v30**
Calibration procedure for the data acquisition electronics (DAE)

Calibration date: **November 14, 2024**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature $(22 \pm 3)^{\circ}\text{C}$ and humidity $< 70\%$.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Keithley Multimeter Type 2001	SN: 0810278	27-Aug-24 (No:40547)	Aug-25
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Auto DAE Calibration Unit	SE UWS 053 AA 1001	23-Jan-24 (in house check)	In house check: Jan-25
Calibrator Box V2.1	SE UMS 006 AA 1002	23-Jan-24 (in house check)	In house check: Jan-25

Calibrated by:	Name Adrian Gehring	Function Laboratory Technician	Signature
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Approved by:	Sven Kühn	Technical Manager
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Issued: November 14, 2024

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Glossary

DAE	data acquisition electronics
Connector angle	information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

- **DC Voltage Measurement:** Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- **Connector angle:** The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
 - **DC Voltage Measurement Linearity:** Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
 - **Common mode sensitivity:** Influence of a positive or negative common mode voltage on the differential measurement.
 - **Channel separation:** Influence of a voltage on the neighbor channels not subject to an input voltage.
 - **AD Converter Values with inputs shorted:** Values on the internal AD converter corresponding to zero input voltage
 - **Input Offset Measurement:** Output voltage and statistical results over a large number of zero voltage measurements.
 - **Input Offset Current:** Typical value for information; Maximum channel input offset current, not considering the input resistance.
 - **Input resistance:** Typical value for information: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
 - **Low Battery Alarm Voltage:** Typical value for information. Below this voltage, a battery alarm signal is generated.
 - **Power consumption:** Typical value for information. Supply currents in various operating modes.

DC Voltage Measurement

A/D - Converter Resolution nominal

High Range: 1LSB = 6.1 μ V , full range = -100...+300 mV

Low Range: 1LSB = 61 nV , full range = -1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	403.661 \pm 0.02% (k=2)	403.375 \pm 0.02% (k=2)	404.261 \pm 0.02% (k=2)
Low Range	3.98099 \pm 1.50% (k=2)	4.00380 \pm 1.50% (k=2)	3.98504 \pm 1.50% (k=2)

Connector Angle

Connector Angle to be used in DASY system	138.5 ° \pm 1 °
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Appendix (Additional assessments outside the scope of SCS0108)

1. DC Voltage Linearity

High Range	Reading (μV)	Difference (μV)	Error (%)
Channel X + Input	199997.30	-0.08	-0.00
Channel X + Input	20004.96	1.27	0.01
Channel X - Input	-19999.95	1.13	-0.01
Channel Y + Input	199996.66	-0.38	-0.00
Channel Y + Input	20003.37	-0.22	-0.00
Channel Y - Input	-20002.10	-0.72	0.00
Channel Z + Input	199998.67	1.91	0.00
Channel Z + Input	20002.42	-1.15	-0.01
Channel Z - Input	-20003.76	-2.46	0.01

Low Range	Reading (μV)	Difference (μV)	Error (%)
Channel X + Input	2003.21	0.87	0.04
Channel X + Input	202.94	0.43	0.21
Channel X - Input	-197.11	0.14	-0.07
Channel Y + Input	2003.03	0.92	0.05
Channel Y + Input	201.93	-0.44	-0.22
Channel Y - Input	-197.91	-0.50	0.26
Channel Z + Input	2002.59	0.48	0.02
Channel Z + Input	201.36	-0.98	-0.48
Channel Z - Input	-198.92	-1.50	0.76

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	-2.95	-4.80
	- 200	5.42	4.18
Channel Y	200	16.24	15.86
	- 200	-17.69	-17.96
Channel Z	200	13.83	13.41
	- 200	-16.44	-16.27

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (μV)	Channel Z (μV)
Channel X	200	-	1.30	-5.23
Channel Y	200	9.03	-	3.45
Channel Z	200	9.51	6.75	-

4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	16121	15307
Channel Y	15813	15894
Channel Z	15723	15030

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10M Ω

	Average (μ V)	min. Offset (μ V)	max. Offset (μ V)	Std. Deviation (μ V)
Channel X	0.73	-0.15	1.46	0.31
Channel Y	-0.58	-1.54	0.19	0.35
Channel Z	-1.16	-2.87	1.48	0.55

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance (Typical values for information)

	Zeroing (kOhm)	Measuring (MOhm)
Channel X	200	200
Channel Y	200	200
Channel Z	200	200

8. Low Battery Alarm Voltage (Typical values for information)

Typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

9. Power Consumption (Typical values for information)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.01	+6	+14
Supply (- Vcc)	-0.01	-8	-9



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Accreditation No.: SCS 0108

Client

BTL Inc.
Guangdong

Certificate No.

EX-3809_Jan25

CALIBRATION CERTIFICATE

Object

EX3DV4 - SN:3809

Calibration procedure(s)

QA CAL-01.v10, QA CAL-12.v10, QA CAL-14.v7, QA CAL-23.v6,
QA CAL-25.v8
Calibration procedure for dosimetric E-field probes

Calibration date

January 24, 2025

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature $(22 \pm 3)^\circ\text{C}$ and humidity $< 70\%$.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID	Calibration Date (Certificate No.)	Sched. Cal.
Power Sensor R&S NRP-33T	SN: 100967	28-Mar-24 (No. 217-04038)	Mar-25
Short [S6019i] + Attenuator [S6020i]	SN: L1119	26-Mar-24 (No. 217-04048)	Mar-25
OCP DAK-12	SN: 1016	24-Sept-24 (No. OCP-DAK12-1016_Sep24)	Sep-25
OCP DAK-3.5	SN: 1249	23-Sept-24 (No. OCP-DAK3.5-1249_Sep24)	Sep-25
Reference Probe EX3DV4	SN: 7349	10-Jan-25 (No. EX3-7349_Jan25)	Jan-26
DAE4	SN: 1301	07-Nov-24 (No. DAE4-1301_Nov24)	Nov-25

Secondary Standards	ID	Check Date (in house)	Sched. Check
ACAP 2020 Calibration Box	SN: L1404	30-Sept-24 (No. Report_ACAP2020E-Cave_20240930s)	Sep-25

	Name	Function	Signature
Calibrated by	Aidonia Georgiadou	Laboratory Technician	
Approved by	Sven Kühn	Technical Manager	

Issued: January 24, 2025

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Accreditation No.: SCS 0108

Glossary

TSL	tissue simulating liquid
NORM _{x,y,z}	sensitivity in free space
ConvF	sensitivity in TSL / NORM _{x,y,z}
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A, B, C, D	modulation dependent linearization parameters
Polarization φ	φ rotation around probe axis
Polarization ϑ	ϑ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\vartheta = 0$ is normal to probe axis
Connector Angle	information used in DASY system to align probe sensor X to the robot coordinate system

Calibration is Performed According to the Following Standards:

- IEC/IEEE 62209-1528, "Measurement Procedure For The Assessment Of Specific Absorption Rate Of Human Exposure To Radio Frequency Fields From Hand-Held And Body-Worn Wireless Communication Devices – Part 1528: Human Models, Instrumentation And Procedures (Frequency Range of 4 MHz to 10 GHz)", October 2020.
- KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz"

Methods Applied and Interpretation of Parameters:

- NORM_{x,y,z}**: Assessed for E-field polarization $\vartheta = 0$ ($f \leq 900$ MHz in TEM-cell; $f > 1800$ MHz: R22 waveguide). NORM_{x,y,z} are only intermediate values, i.e., the uncertainties of NORM_{x,y,z} does not affect the E²-field uncertainty inside TSL (see below ConvF).
- NORM(f)_{x,y,z} = NORM_{x,y,z} * frequency_response** (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- DCP_{x,y,z}**: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal. DCP does not depend on frequency nor media.
- PAR**: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- A_{x,y,z}; B_{x,y,z}; C_{x,y,z}; D_{x,y,z}; VR_{x,y,z}**: A, B, C, D are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters**: Assessed in flat phantom using E-field (or Temperature Transfer Standard for $f \leq 800$ MHz) and inside waveguide using analytical field distributions based on power measurements for $f > 800$ MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORM_{x,y,z} * ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from ± 50 MHz to ± 100 MHz.
- Spherical isotropy (3D deviation from isotropy)**: in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset**: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle**: The angle is assessed using the information gained by determining the NORM_x (no uncertainty required).

Parameters of Probe: EX3DV4 - SN:3809

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc ($k = 2$)
Norm ($\mu\text{V}/(\text{V}/\text{m})^2$) ^A	0.47	0.47	0.53	$\pm 10.1\%$
DCP (mV) ^B	100.3	99.8	99.6	$\pm 4.7\%$

Calibration Results for Modulation Response

UID	Communication System Name		A dB	B dB $\sqrt{\mu\text{V}}$	C	D dB	VR mV	Max dev.	Max Unc ^E $k = 2$
0	CW	X	0.00	0.00	1.00	0.00	145.9	$\pm 1.0\%$	$\pm 4.7\%$
		Y	0.00	0.00	1.00		124.5		
		Z	0.00	0.00	1.00		131.2		
10352	Pulse Waveform (200Hz, 10%)	X	20.00	93.81	22.29	10.00	60.0	$\pm 2.8\%$	$\pm 9.6\%$
		Y	20.00	91.35	20.86		60.0		
		Z	20.00	92.61	22.00		60.0		
10353	Pulse Waveform (200Hz, 20%)	X	20.00	99.42	24.15	6.99	80.0	$\pm 1.4\%$	$\pm 9.6\%$
		Y	20.00	93.15	20.46		80.0		
		Z	20.00	93.78	21.72		80.0		
10354	Pulse Waveform (200Hz, 40%)	X	20.00	103.19	24.64	3.98	95.0	$\pm 1.3\%$	$\pm 9.6\%$
		Y	20.00	97.10	20.90		95.0		
		Z	20.00	98.06	22.64		95.0		
10355	Pulse Waveform (200Hz, 60%)	X	20.00	112.74	27.79	2.22	120.0	$\pm 1.3\%$	$\pm 9.6\%$
		Y	20.00	102.67	22.21		120.0		
		Z	20.00	104.07	24.27		120.0		
10387	QPSK Waveform, 1 MHz	X	1.80	66.77	15.54	1.00	150.0	$\pm 1.8\%$	$\pm 9.6\%$
		Y	1.64	65.52	14.57		150.0		
		Z	1.71	65.46	14.84		150.0		
10388	QPSK Waveform, 10 MHz	X	2.40	68.90	16.26	0.00	150.0	$\pm 1.1\%$	$\pm 9.6\%$
		Y	2.16	67.23	15.29		150.0		
		Z	2.24	67.53	15.52		150.0		
10396	64-QAM Waveform, 100 kHz	X	2.82	69.55	18.41	3.01	150.0	$\pm 0.8\%$	$\pm 9.6\%$
		Y	2.66	68.65	17.88		150.0		
		Z	3.08	70.57	18.76		150.0		
10399	64-QAM Waveform, 40 MHz	X	3.50	66.98	15.78	0.00	150.0	$\pm 0.8\%$	$\pm 9.6\%$
		Y	3.52	66.96	15.64		150.0		
		Z	3.55	66.97	15.71		150.0		
10414	WLAN CCDF, 64-QAM, 40 MHz	X	4.85	65.46	15.48	0.00	150.0	$\pm 1.6\%$	$\pm 9.6\%$
		Y	4.71	65.01	15.17		150.0		
		Z	4.95	65.60	15.51		150.0		

Note: For details on UID parameters see Appendix

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor $k=2$, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^A The uncertainties of Norm X,Y,Z do not affect the E^2 -field uncertainty inside TSL (see Page 5).

^B Linearization parameter uncertainty for maximum specified field strength.

^E Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

Parameters of Probe: EX3DV4 - SN:3809

Sensor Model Parameters

	C1 fF	C2 fF	α V^{-1}	T1 $ms V^{-2}$	T2 $ms V^{-1}$	T3 ms	T4 V^{-2}	T5 V^{-1}	T6
x	48.1	356.76	35.19	16.04	0.00	5.10	0.61	0.32	1.01
y	44.3	329.85	35.34	9.54	0.30	5.04	0.75	0.28	1.01
z	50.3	375.74	35.49	24.63	0.01	5.10	1.39	0.27	1.01

Other Probe Parameters

Sensor Arrangement	Triangular
Connector Angle	-15.6°
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	9 mm
Tip Diameter	2.5 mm
Probe Tip to Sensor X Calibration Point	1 mm
Probe Tip to Sensor Y Calibration Point	1 mm
Probe Tip to Sensor Z Calibration Point	1 mm
Recommended Measurement Distance from Surface	1.4 mm

Note: Measurement distance from surface can be increased to 3–4 mm for an *Area Scan* job.